

# LVDS QUAD DIFFERENTIAL LINE DRIVER

### FEATURES

- >400 Mbps (200 MHz) Signaling Rates
- Flow-Through Pinout Simplifies PCB Layout
- 300 ps Maximum Differential Skew
- Propagation Delay Times 1.8 ns (Typical)
- 3.3 V Power Supply Design

RUMENTS

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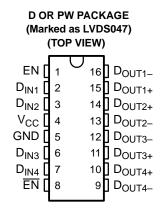
- ±350 mV Differential Signaling
- High Impedance on LVDS Outputs on Power
   Down
- Conforms to TIA/EIA-644 LVDS Standard
- Industrial Operating Temperature Range (-40°C to 85°C)
- Available in SOIC and TSSOP Packages

## DESCRIPTION

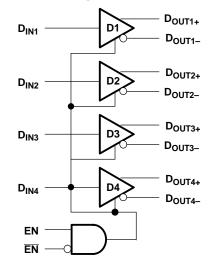
The SN65LVDS047 is a quad differential linedriver that implements the electrical characteristics of low-voltage differential signaling (LVDS). This signaling technique lowers the output voltage levels of 5-V differential standard levels (such as EIA/TIA-422B) to reduce the power, increase the switching speeds, and allow operation with a 3.3-V supply rail. Any of the four current-mode drivers will deliver a minimum differential output voltage magnitude of 247 mV into a 100- $\Omega$  load when enabled.

The intended application of this device and signaling technique is for point-to-point and multi-drop baseband data transmission over controlled impedance media of approximately  $100 \Omega$ . The transmission media may be printed-circuit board traces, backplanes, or cables. The ultimate rate and distance of data transfer is dependent upon the attenuation characteristics of the media, the noise coupling to the environment, and other system characteristics.

The SN65LVDS047 is characterized for operation from -40°C to 85°C.



### functional block diagram



### TRUTH TABLE<sup>(1)</sup>

INPUT	ENA	BLES	OUT	PUTS
D <sub>IN</sub>	EN	EN	D <sub>OUT+</sub>	D <sub>OUT-</sub>
L	н	L or OPEN	L	Н
Н		LOTOPEN	Н	L
Х	All other of	conditions	Z	Z

(1) H = high level, L = low level, X = irrelevant, Z = high impedance (off)



## SN65LVDS047

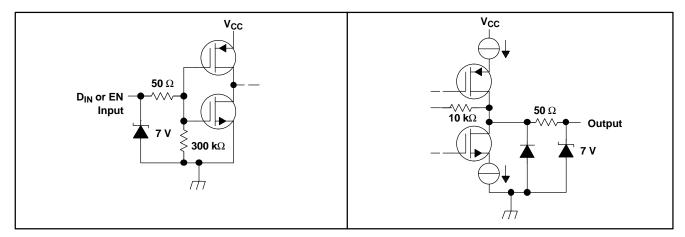


#### SLLS416B-JUNE 2000-REVISED DECEMBER 2003



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### EQUIVALENT INPUT AND OUTPUT SCHEMATIC DIAGRAMS



### **ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>**

over operating free-air temperature (see <sup>(2)</sup> range (unless otherwise noted)

		UNIT
(V <sub>CC</sub> )	Supply voltage	-0.3 V to 4 V
V <sub>I</sub> (D <sub>IN</sub> )	Input voltage range	-0.3 V to (V <sub>CC</sub> +0.3 V)
(EN, <u>EN</u> )	Enable input voltage	-0.3 V to (V <sub>CC</sub> +0.3 V)
V <sub>O</sub> (D <sub>OUT+</sub> ,D <sub>OUT-</sub> )	Output voltage	-0.5 V to (V <sub>CC</sub> +0.5 V)
(D <sub>OUT+</sub> ,D <sub>OUT-</sub> )	Bus-pinelectrostatic discharge, see <sup>(3)</sup>	>10 kV
(D <sub>OUT+</sub> ,(D <sub>OUT-</sub> )	Short circuit duration	Continuous
	Storage temperature range	-65°C to 150°C
	Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values, except differential I/O bus voltages, are with respect to network ground terminal.

(3) Tested in accordance with MIL-STD-883C Method 3015.7.

#### **DISSIPATION RATING TABLE**

PACKAGE	T <sub>A</sub> ≤ 25°C POWER RATING	OPERATING FACTOR <sup>(1)</sup> ABOVE $T_A = 25^{\circ}C$	T <sub>A</sub> = 85°C POWER RATING		
D	950 mW	7.6 mW/°C	494 mW		
PW	774 mW	6.2 mW/°C	402 mW		

(1) This is the inverse of the junction-to-ambient thermal resistance when board-mounted and with no air flow.

### **RECOMMENDED OPERATING CONDITIONS**

		MIN	NOM	MAX	UNIT
V <sub>CC</sub>	Supply voltage	3	3.3	3.6	V
T <sub>A</sub>	Operating free-air temperature	-40	25	85	°C

### **ELECTRICAL CHARACTERISTICS**

over recommended operating free-air temperature range (see <sup>(1)</sup> and <sup>(2)</sup>) (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(3)</sup>	MAX	UNIT
V <sub>OD</sub>	Differential output voltage		250 310			mV
n V <sub>OD</sub>	Change in magnitude of V <sub>OD</sub> for complementary output states			1	35	mV
V <sub>OC(SS)</sub>	Steady-state, common-mode output voltage		1.125	1.17	1.375	V
nV <sub>OC(SS)</sub>	Change in steady-state common-mode output voltage between logic states	$R_L = 100 \Omega$ , see Figure 1		1	25	mV
V <sub>OH</sub>	Output high voltage			1.33	1.6	V
V <sub>OL</sub>	Output low voltage		0.90	1.02		V
V <sub>IH</sub>	Input high voltage		2		V <sub>CC</sub>	V
V <sub>IL</sub>	Input low voltage		GND		0.8	V
IIH	Input high current	$V_{IN} = V_{CC} \text{ or } 2.5 \text{ V}$	-10	3	10	μA
IIL	Input low current	V <sub>IN</sub> = GND or 0.4 V	-10	1	10	μA
V <sub>IK</sub>	Input clamp voltage	I <sub>CL</sub> = -18 mA	-1.5	-0.8		V
I <sub>OS</sub>	Output short circuit current, see <sup>(4)</sup>	Enabled, $D_{IN} = V_{CC}$ , $D_{OUT+} = 0$ V or $D_{IN} = GND$ , $D_{OUT-} = 0$ V		-3.1	-9	mA
I <sub>OSD</sub>	Differential output short circuit current, see <sup>(4)</sup>	Enabled, V <sub>OD</sub> = 0 V			-9	mA
I <sub>OFF</sub>	Power-off leakage	$V_O = 0 V \text{ or } 3.6 V, V_{CC} = 0 V \text{ or}$ Open	-1		1	μΑ
I <sub>OZ</sub>	Output 3-state current	EN = 0.8 V and $\overline{EN}$ = 2 V, V <sub>O</sub> = 0 V or V <sub>CC</sub>	-1		1	μΑ
I <sub>CC</sub>	No load supply current, drivers enabled	D <sub>IN</sub> = V <sub>CC</sub> or GND		7		mA
I <sub>CCL</sub>	Loaded supply current, drivers enabled	$R_L$ = 100 $\Omega$ all channels, $D_{IN}$ = $V_{CC}$ or GND (all inputs)		20	26	mA
I <sub>CC(Z)</sub>	No load supply current, drivers disabled	$\frac{D_{IN}}{EN} = V_{CC} \text{ or GND, EN} = GND,$ $\frac{D_{IN}}{EN} = V_{CC}$		0.5	1.3	mA

Current into device pin is defined as positive. Current out of the device is defined as negative. All voltages are referenced to ground, (1) unless otherwise specified.

The SN65LVDS047 is a current mode device and only functions within data sheet specifications when a resistive load is applied to the (2)driver outputs, 90  $\Omega$  to 110  $\Omega$  typical range.

(3) All typical values are given for: V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C.
(4) Output short circuit current (I<sub>OS</sub>) is specified as magnitude only, minus sign indicates direction only.

#### SWITCHING CHARACTERISTICS

over recommended operating conditions (see (1), (2) and (3) )(unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP( 4)	MAX	UNIT
t <sub>PHL</sub>	Differential propagation delay, high-to-low		1.4	1.8	2.8	ns
t <sub>PLH</sub>	Differential propagation delay, low-to-high		1.4	1.8	2.8	ns
t <sub>SK(p)</sub>	Differential pulse skew (t <sub>PHLD</sub> - t <sub>PLHD</sub> ), see <sup>(5)</sup>			50	300	ps
t <sub>SK(o)</sub>	Channel-to-channel skew, see (6)	R <sub>L</sub> = 100 Ω,, C <sub>L</sub> = 15 pF,		40	300	ps
t <sub>SK(pp)</sub>	Differential part-to-part skew, see (7)	see Figure 2 and Figure 3			1	ns
t <sub>SK(lim)</sub>	Differential part-to-part skew, see (8)				1.2	ns
t <sub>r</sub>	Rise time			0.5	1.5	ns
t <sub>f</sub>	Fall time			0.5	1.5	ns
t <sub>PHZ</sub>	Disable time high to Z			5.5	8	ns
t <sub>PLZ</sub>	Disable time low to Z	$R_1 = 100 \Omega_2, C_1 = 15 \text{ pF},$		5.5	8	ns
t <sub>PZH</sub>	Enable time Z to high	see Figure 4 and Figure 5		8.5	12	ns
t <sub>PZL</sub>	Enable time Z to low			8.5	12	ns
f <sub>(MAX)</sub>	Maximum operating frequency, see <sup>(9)</sup>			250		MHz

Generator waveform for all tests unless otherwise: f = 1 MHz,  $Z_0 = 50 \Omega$ ,  $t_r < 1$  ns, and  $t_f < 1$  ns. (1)

 $\mathrm{C}_{\mathrm{L}}$  includes probe and jig capacitance. (2)

(3) All input voltages are for one channel unless otherwise specified. Other inputs are set to GND.

- (4)
- All typical values are given for:  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .  $t_{SK(p)}|t_{PHL}-t_{PLH}|$  is the magnitude difference in differential propagation delay time between the positive going edge and the negative going (5) edge of the same channel.

 $t_{SK(o)}$  is the differential channel-to-channel skew of any event on the same device. (6)

t<sub>SK(pp)</sub> is the differential part-to-part skew, and is defined as the difference between the minimum and the maximum specified differential (7) propagation delays. This specification applies to devices at the same V<sub>CC</sub> and within 5°C of each other within the operating temperature range.

- t<sub>SK(lim)</sub> part-to-part skew, is the differential channel-to-channel skew of any event between devices. This specification applies to devices (8) over recommended operating temperature and voltage ranges, and across process distribution. t<sub>SK(lim)</sub> is defined as|Min - Max| differential propagation delay.
- $f_{(MAX)}$  generator input conditions:  $t_r = t_f < 1$  ns (0% to 100%), 50% duty cycle, 0 V to 3 V. Output criteria: duty cycle = 45% to55,  $V_{OD} > 250$  mV, all channels switching (9)

### PARAMETER MEASUREMENT INFORMATION

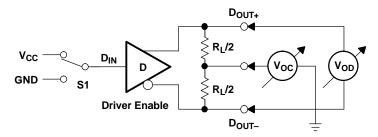


Figure 1. Driver  $V_{\text{OD}}$  and  $V_{\text{OC}}$  Test Circuit

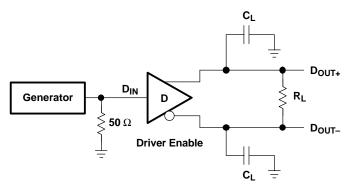


Figure 2. Driver Propagation Delay and Transition Time Test Circuit

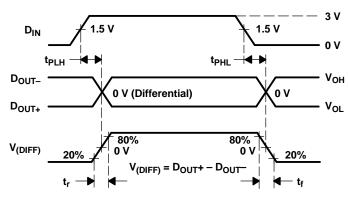
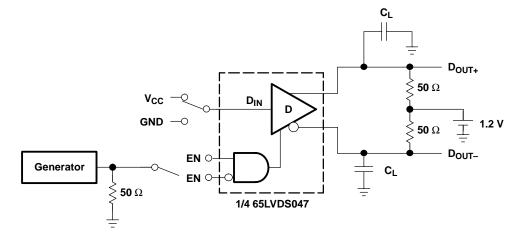


Figure 3. Driver Propagation Delay and Transition Time Waveforms

#### PARAMETER MEASUREMENT INFORMATION (continued)





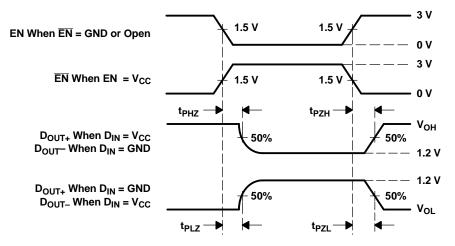
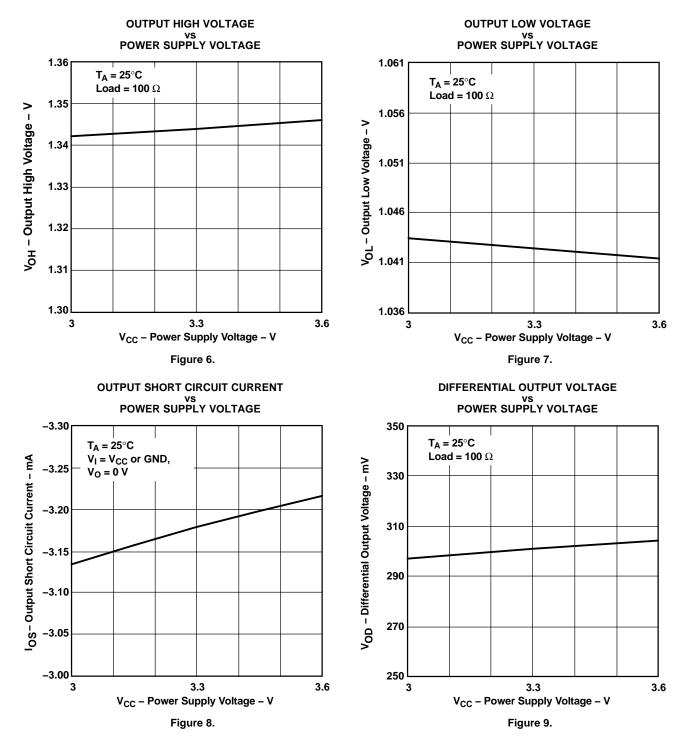


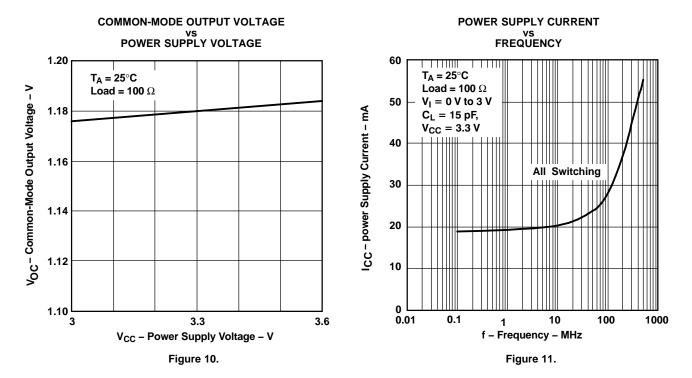
Figure 5. Driver 3-State Delay Waveform

#### **TYPICAL CHARACTERISTICS**





## **TYPICAL CHARACTERISTICS (continued)**





6-Feb-2020

## PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
SN65LVDS047D	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVDS047	Samples
SN65LVDS047DG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVDS047	Samples
SN65LVDS047DR	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVDS047	Samples
SN65LVDS047PW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVDS047	Samples
SN65LVDS047PWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVDS047	Samples
SN65LVDS047PWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVDS047	Samples
SN65LVDS047PWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVDS047	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



## PACKAGE OPTION ADDENDUM

6-Feb-2020

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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## PACKAGE MATERIALS INFORMATION

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### TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN65LVDS047DR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
SN65LVDS047PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

TEXAS INSTRUMENTS

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## PACKAGE MATERIALS INFORMATION

26-Feb-2019



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN65LVDS047DR	SOIC	D	16	2500	350.0	350.0	43.0
SN65LVDS047PWR	TSSOP	PW	16	2000	350.0	350.0	43.0

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



4211283-4/E 08/12

# D (R-PDSO-G16) PLASTIC SMALL OUTLINE Stencil Openings (Note D) Example Board Layout (Note C) –16x0,55 -14x1,27 -14x1,27 16x1,50 5,40 5.40 Example Non Soldermask Defined Pad Example Pad Geometry (See Note C) 0,60 .55 Example 1. Solder Mask Opening (See Note E) -0,07 All Around

NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
   E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



# **PW0016A**



# **PACKAGE OUTLINE**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



# PW0016A

# **EXAMPLE BOARD LAYOUT**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# PW0016A

# **EXAMPLE STENCIL DESIGN**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

9. Board assembly site may have different recommendations for stencil design.



<sup>8.</sup> Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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